

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at www.onsemi.com

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, emplo



January 2002 Revised September 2002

FIN1101

LVDS Single Port High Speed Repeater

General Description

This single port repeater is designed for high speed interconnects utilizing Low Voltage Differential Signaling (LVDS) technology. It accepts and outputs LVDS levels with a typical differential output swing of 330 mV which provides low EMI at ultra low power dissipation even at high frequencies. It can directly accept multiple differential I/O including: LVPECL, HSTL, and SSTL-2 for translating directly to LVDS.

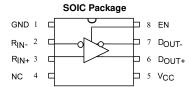
Features

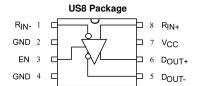
- Up to 1.6 Gb/s full differential path
- 3.5 ps max random jitter and 135 ps max deterministic iitter
- 3.3V power supply operation
- Wide rail-to-rail common mode range
- Ultra low power consumption
- LVDS receiver inputs accept LVPECL, HSTL, and SSTL-2 directly
- Power off protection
- 7 kV HBM ESD protection (all pins)
- Meets or exceed the TA/EIA-644-A LVDS standard
- Packaged in 8-pin SOIC and US8
- Open circuit fail safe protection

Ordering Code:

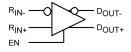
Order Number	Package Number	Package Description
FIN1101M	M08A	8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow [TUBE]
FIN1101MX		8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow [TAPE and REEL]
FIN1101K8X	MAB08A	8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide [TAPE and REEL]

Connection Diagrams





Functional Diagram



Pin Descriptions

Pin Name	Description			
R _{IN+}	Non-Inverting LVDS Inputs			
R _{IN-}	Inverting LVDS Inputs			
D _{OUT+}	Non-Inverting Driver Outputs			
D _{OUT}	Inverting Driver Outputs			
EN	Driver Enable Pin			
V _{CC}	Power Supply			
GND	Ground			

Function Table

I		Inputs	Outputs			
I	EN R _{IN+}		R _{IN}	D _{OUT+}	D _{OUT} _	
	Н	Н	L	Н	L	
	Н	L	Н	L	Н	
	Н	Fail Saf	e Case	Н	L	
	L	Х	Х	Z	Z	

H = HIGH Logic Level

L = LOW Logic Level Z = High Impedance

Absolute Maximum Ratings(Note 1)

 $\label{eq:total_stress} Storage\ Temperature\ Range\ (T_{STG}) \qquad -65^{\circ}C\ to\ +150^{\circ}C$ Max Junction Temperature (T_J) $\qquad \qquad 150^{\circ}C$

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C ESD (Human Body Model) 7000V

ESD (Machine Model) 300V

Recommended Operating Conditions

Supply Voltage (V_{CC}) 3.0V to 3.6V Operating Temperature (T_A) -40° C to $+85^{\circ}$ C

Magnitude of Input

Differential Voltage ($|V_{ID}|$) 100 mV to V_{CC}

150°C Common Mode Input Voltage

 (V_{IC}) $(0V + |V_{ID}|/2)$ to $(V_{CC} - |V_{ID}|/2)$

Note 1: The "Absolute Maximum Ratings": are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature and output/input loading variables. Fairchild does not recommend operation of circuits outside databook specification.

DC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions		Min	Typ (Note 2)	Max	Units
V _{TH}	Differential Input Threshold HIGH	See Figure 1; V _{IC} = +0.05V, +1.2V, or (V _{CC} - 0.05V)				100	mV
V _{TL}	Differential Input Threshold LOW	See Figure 1; $V_{IC} = +0.05V$, $+1.2V$, or (V_{CC})	– 0.05V)	-100			mV
V _{IH}	Input High Voltage (EN)			2.0		V _{CC}	٧
V _{IL}	Input Low Voltage (EN)			GND		0.8	٧
V _{OD}	Output Differential Voltage			250	330	450	mV
ΔV_{OD}	V _{OD} Magnitude Change from	$R_L = 100 \Omega$, Driver Enabled,				25	mV
	Differential LOW-to-HIGH	See Figure 2				25	IIIV
V _{OS}	Offset Voltage			1.125	1.23	1.375	٧
ΔV _{OS}	Offset Magnitude Change from					25	mV
	Differential LOW-to-HIGH					25	IIIV
los	Short Circuit Output Current	D _{OUT+} = 0V & D _{OUT-} = 0V, Driver Enabled			-3.4	-6	mA
		V _{OD} = 0V, Driver Enabled			±3.4	±6	mA
I _{IN}	Input Current (EN, D _{INX+} , D _{INX-})	$V_{IN} = 0V \text{ to } V_{CC},$				±20	μА
		Other Input = V _{CC} or 0V (for Differential Inp	uts)			±20	μΛ
I _{OFF}	Power-Off Input or Output Current	$V_{CC} = 0V$, V_{IN} or $V_{OUT} = 0V$ to 3.6V				±20	μΑ
I _{CCZ}	Disabled Power Supply Current	Drivers Disabled			3.2	5.5	mA
Icc	Power Supply Current	Drivers Enabled, Any Valid Input Condition			9.3	13.5	mA
l _{OZ}	Disabled Output Leakage Current	Driver Disabled, D _{OUT+} = 0V to 3.6V or				100	
		D _{OUT} = 0V to 3.6V				±20	μΑ
V _{IC}	Common Mode Voltage Range	$ V_{ID} = 100 \text{ mV to } V_{CC}$		$0V + V_{ID} /2$		V _{CC} - (V _{ID} /2)	٧
_	Input Capacitance	E	N Input		2.2		pF
C _{IN}		D	ata Input		2.0		þг
C _{OUT}	Output Capacitance				2.6		pF

Note 2: All typical values are at $T_A = 25^{\circ}C$ and with $V_{CC} = 3.3V$.

AC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

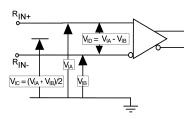
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
				(Note 3)		
t _{PLHD}	Differential Propagation Delay		0.75	1.1	1.75	ns
	LOW-to-HIGH		0.75	1.1	1.75	115
t _{PHLD}	Differential Propagation Delay	$R_L = 100 \Omega, C_L = 5 pF,$	0.75	1.1	1.75	
	HIGH-to-LOW	$V_{ID} = 200 \text{ mV to } 450 \text{ mV},$	0.75	1.1	1.75	ns
t _{TLHD}	Differential Output Rise Time (20% to 80%)	$V_{IC} = V_{ID} /2 \text{ to } (V_{CC-} (V_{ID}/2),$	0.29	0.40	0.58	ns
t _{THLD}	Differential Output Fall Time (80% to 20%)	Duty Cycle = 50%,	0.29	0.40	0.58	ns
t _{SK(P)}	Pulse Skew t _{PLH} - t _{PHL}	See Figure 3 and Figure 4		0.01	0.2	ns
t _{SK(PP)}	Part-to-Part Skew (Note 4)				0.5	ns
f _{MAX}	Maximum Frequency (Note 5)(Note 6)		400	800		MHz
t _{PZHD}	Differential Output Enable Time from Z to HIGH			2.1	5	ns
t _{PZLD}	Differential Output Enable Time from Z to LOW	$R_L = 100 \Omega, C_L = 5 pF,$		2.3	5	ns
t _{PHZD}	Differential Output Disable Time from HIGH to Z	See Figure 2 and Figure 3		1.5	5	ns
t _{PLZD}	Differential Output Disable Time from LOW to Z			1.8	5	ns
t _{DJ}	LVDS Data Jitter,	$V_{ID} = 300 \text{ mV}, PRBS = 2^{23} - 1,$		85	135	ne
	Deterministic	V _{IC} = 1.2V at 800 Mbps		0.5	133	ps
t _{RJ}	LVDS Clock Jitter, Random	V _{ID} = 300 mV		2.1	3.5	ps
	(RMS)	V _{IC} = 1.2 V at 400 MHz		2.1	5.5	μs

Note 3: All typical values are at T_A = 25°C and with V_{CC} = 3.3V, V_{ID} = 300mV, V_{IC} = 1.2V unless otherwise specified.

Note 4: t_{SK(PP)} is the magnitude of the difference in differential propagation delay times between identical channels of two devices switching in the same direction (either LOW-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits.

Note 5: Passing criteria for maximum frequency is the output V_{OD} > 200 mV and the duty cycle is 45% to 55% with all channels switching.

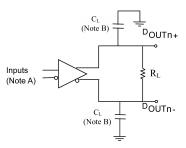
 $\textbf{Note 6:} \ \text{Output loading is transmission line environment only; } \ C_L \ \text{is} < 1 \ \text{pF of stray test fixture capacitance.}$



HIGH or LOW R_L/2
POUT n- Vos

FIGURE 1. Differential Receiver Voltage Definitions and Propagation I and Transition Time Test Circuit

FIGURE 2. Differential Driver DC Test Circuit



Note A: All LVDS input pulses have frequency = 10MHz, t_R or t_F <= 0.5 ns Note B: C_L includes all probe and test fixture capacitances

FIGURE 3. Differential Driver Propagation Delay and Transition Time Test Circuit

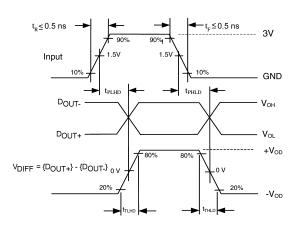
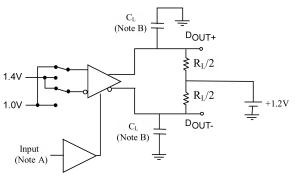


FIGURE 4. AC Waveforms



Note A: All LVTTL input pulses have frequency = 10 MHz, t_R or t_F < = 2 ns Note B: C_L includes all probe and test fixture capacitances

FIGURE 5. Differential Driver Enable and Disable Test Circuit

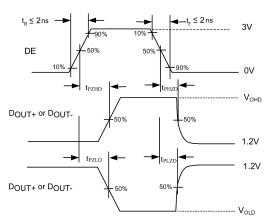
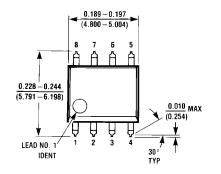
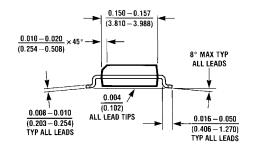
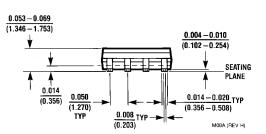


FIGURE 6. Enable and Disable AC Waveforms

Physical Dimensions inches (millimeters) unless otherwise noted

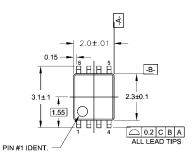


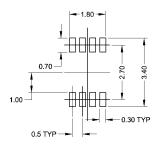




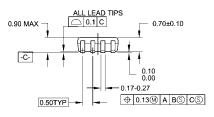
8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M08A

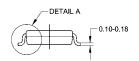
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

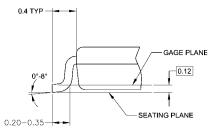




LAND PATTERN RECOMMENDATION







NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-187 B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

DETAIL A

MAB08AREVC

8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide Package Number MAB08A

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor nessure any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, a

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative